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Low-Energy-Spread Ion Bunches from a Trapped Atomic Gas

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We present time-of-flight measurements of the longitudinal energy spread of pulsed ultracold ion beams, produced by near-threshold ionization of rubidium atoms captured in a magneto-optical atom trap. Well-defined pulsed beams have been produced with energies of only 1 eV and a root-mean-square energy spread as low as 0.02 eV, 2 orders of magnitude lower than the state-of-the-art gallium liquid-metal ion source. The low energy spread is important for focused ion beam technology because it enables milling and ion-beam-induced deposition at sub-nm length scales with many ionic species, both light and heavy. In addition, we show that the slowly moving, low-energy-spread ion bunches are ideal for studying intricate space charge effects in pulsed beams. As an example, we present a detailed study of the transition from space charge dominated dynamics to ballistic motion.

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The importance of focused ion beam (FIB) applications for nanotechnology can hardly be overstated. FIBs are used for structuring at the nanometer scale both by accurate removal of material by sputtering and by high precision ion-beam-induced deposition. For this reason FIBs have become indispensable tools for circuit editing in the semiconductor industry [1]. In addition FIBs enable determination of the elemental, isotopic, and molecular composition of surfaces using time-of-flight secondary ion mass spectrometry (TOF SIMS), making TOF SIMS one of the most sensitive surface analysis techniques [2].

FIB performance is presently limited by the properties of the commonly preferred liquid metal ion source (LMIS). The gallium-based LMIS FIB offers the highest spatial resolution. The smallest focal spot size of ~10 nm, is limited by the energy spread of the Ga⁺ source [1]. However, to keep up with Moore’s law, the semiconductor industry will soon require milling and deposition at the 1 nm scale. In addition, for TOF SIMS heavier elements, like cesium, are preferred for their higher sputter yield. In particular the use of TOF SIMS in the life sciences requires projectiles heavier than Ga [3]. Unfortunately this goes at the expense of spatial resolution, which can only be reached at present with the Ga-based LMIS FIB.

Recently a new ion source was proposed, the Ultra Cold Ion Source (UCIS), which is based on extraction of ions from a laser cooled atomic gas [4–6]. The UCIS promises a much smaller energy spread than the LMIS at comparable brightness, enabling ≤ 1 nm focal spot sizes. In addition the UCIS is suited for many elements, in particular the alkali-metal atoms: Cs for TOF SIMS with high spatial resolution and high sputter yield; Li as an alternative for He in the recently developed ion microscope [7].

After first preliminary experiments [8], the UCIS potential of delivering beams of LMIS brightness was recently demonstrated [9]. In this Letter we present detailed TOF energy spread measurements on rubidium ion bunches extracted from a UCIS. We have produced Rb⁺ ion beams with a root-mean-squared (rms) energy spread of only 0.02 eV, 2 orders of magnitude smaller than the state-of-the-art Ga-based LMIS. These extremely low-energy spreads have been realized by extracting ion bunches at energies as low as 1 eV. Since energy spread can be conserved during further acceleration, chromatic aberration can be virtually eliminated at beam energies typical for FIB operation, i.e., 30 keV. In combination with the recently measured brightness of such beams [9], this implies that sub-nm focal spot sizes are within reach for Li⁺, Cs⁺ and many other ionic species.

The extreme degree of control over beam properties afforded by UCISs opens up completely new applications as well. First, ultralow beam energies with meV energy spread and nm spatial resolution allow direct ion deposition, highly controlled excitation of localized surface states, and precision surface chemistry, all without sputter damage.

Second, the UCIS in pulsed mode opens up new regimes of space charge dominated beams at very low velocities. As we show in this Letter, this allows investigation of intricate space charge effects in slow motion (ion velocities of ~10³ m/s) and therefore in great detail. As an example, we have studied the transition from space charge dominated dynamics to ballistic motion. Such a model system is of great importance for the study of ill-understood beam phenomena like space charge-induced instabilities, emittance growth and halo formation. These nonlinear space charge effects play a decisive role in the beam formation for the most demanding applications such as heavy ion fusion, high-energy colliders, and free electron lasers. The only system at the moment fully dedicated to the study of such space charge effects is UMER [10,11], which employs a 10 keV electron beam in a ring.
The basis of a UCIS is a laser cooled and trapped atomic gas inside a magneto-optical trap (MOT), which is ionized by near-threshold photoionization. By applying an electric field a cold ion beam is created, as is schematically illustrated in Fig. 1. The thermal energy of these ions ($100 \mu K \sim 10^{-8}$ eV) is very low, giving rise to a very high brightness. An additional longitudinal energy spread is introduced due to the initial longitudinal size of the ionization volume. A more detailed description of the source and its expected performance is given in our previous paper [4].

In our experiments we use $^{85}\text{Rb}$ in a standard vapor cell MOT configuration [12], which consists of 3 orthogonal pairs of circularly polarized 780 nm laser beams. A quadrupole magnetic field with a gradient of $10 \text{ G/cm}$ is produced by two coils in anti-Helmholtz configuration placed around the accelerator inside the vacuum chamber. Typically $10^7-10^8$ Rb atoms are captured in a cloud with a Gaussian density distribution with an rms radius of 1 mm and a central density of $10^9-10^{10}$ atoms/cm$^3$. To produce ions a two step photo-ionization scheme is used. First Rb atoms are excited to the $5p$ level by the trapping laser, from where the atoms are ionized by a 2.5 ns rms, 480 nm pulsed dye laser tuned just above the ionization threshold. The ionization laser beam is focused through the cold atom cloud in a direction perpendicular to the electric field (see Fig. 1). In this way a cylinder of charged particles is created with an rms radius $\sigma_R = 32 \pm 1 \mu$m.

dc voltages up to $V_A = 5 \text{ kV}$ are applied across the electrodes, which are approximately 20 mm apart. For technical details of the accelerator structure, see Ref. [13]. The quadrupole magnetic field is kept on, but this has a negligible effect on the trajectories. Charged particles are created at the center of the acceleration region, in a local electric field $E_0 = V_A/d_{\text{eff}}$, where $d_{\text{eff}} = 27 \text{ mm}$. They travel about 10 mm before exiting the accelerator, resulting in an energy of $U = 0.49 \text{ eV}V_A$. The size $\sigma_R$ of the ionization volume in the accelerator field $E_0$ gives rise to an initial rms energy spread

$$\sigma_U = e\sigma_RE_0,$$

so that $(\sigma_U/U)_{\text{initial}} = 0.2\%$ for $\sigma_R = 32 \mu$m.

At a distance of 29 cm from the accelerator center a MCP detector assembly is used to detect the ions. The temporal distribution is measured by recording the time-dependent current with a transimpedance amplifier. The rms time resolution $\tau_D$ of the detection system is $9 \pm 1 \text{ ns}$, which also includes the laser pulse length.

Time-of-flight (TOF) measurements have been performed by pulsed photo-ionization of the cold atoms in the dc acceleration field. The time-dependent current is recorded on an oscilloscope, together with a photodiode signal of the pulsed laser. The charge $Q$ in a bunch is measured with 5% accuracy by integrating the current signal. Both the photodiode signal and the current signal are fitted with a gaussian distribution to determine the average TOF $T$ and the rms bunch length $\sigma_T$. The relative spread in arrival time $\sigma_T/T$ is a measure for the longitudinal energy spread $\sigma_U/U$ in the bunch:

$$\frac{\sigma_U}{U} = 2 \frac{\sigma_T}{T} \frac{1}{(1-\epsilon)},$$

where $\epsilon \approx 0.13$ is a geometric correction factor.

Measurements of the energy spread as function of the beam energy are shown in Fig. 2. Different curves correspond to different amounts of charge in a bunch, ranging from $Q = 0.026 \text{ fC}$ to $Q = 13 \text{ fC}$. The results shown are averages over 10 bunches. At higher voltages $\sigma_T$ is close to the time constant $\tau_D$ of the detection system, so a deconvolution is performed by quadratically subtracting $\tau_D$.

Two different regions can be clearly observed in the plot. At higher acceleration voltages the curves of the different

![FIG. 1 (color online). A schematic overview of the experimental setup. A cold cloud of rubidium (a) is trapped inside a cylindrically symmetric accelerator structure (b). After pulsed ionization (c), ions are accelerated to the MCP detector (d) where the temporal distribution is measured (e).](image-1)

![FIG. 2 (color). Measured energy spread $\sigma_U$ as function of the beam energy $U$ for various bunch charges (scatter plots) together with the results of the GPT simulations (dotted and solid curves). The dotted curves have been calculated directly in the GPT simulations; the solid curves have been calculated by applying the TOF procedure of Eq. (2).](image-2)
bunch charges coincide, implying that space charge forces only play a minor role. In this region the relative energy spread $\sigma_U/U$ is less than 0.2%, as expected on the basis of Eq. (1). At lower voltages, however, the curves clearly depend on the charge in the bunch, and thus space charge is important in this region. With beam energies as low as 1 eV, this is not unexpected. At these low energies it is possible to produce beams with an rms energy spread $\sigma_U = 0.02$ eV, 2 orders of magnitude lower than the LMIS.

To get a better understanding of the behavior, particle tracking simulations have been performed with the use of the GPT code [14]. The dc electric field inside the accelerator has been calculated with the Superfish poisson solver [15]. All the ions in the bunch are tracked individually with all mutual Coulomb interactions included, using the Barnes Hutt algorithm [16] to reduce the calculation time. In Fig. 2 the simulation results are shown for five different charges. The directly calculated energy spread is indicated by dotted curves. Also the same procedure used in the experiment can be performed, by using Eq. (2) (shown as solid lines). Both are in remarkably good agreement with the experimental data, without any fit parameter.

The observed behavior can be fully explained in terms of space charge forces and acceleration fields, the only ingredients in the GPT simulation. This implies that all the data can be scaled to a single curve by dividing both the acceleration voltage and the observed energy spread by the bunch charge, as shown in Fig. 3.

The energy spread at higher acceleration voltages is dominated by the initial spread in position in the acceleration field due the size of the ionization volume, as described by Eq. (1). In this region the energy spread depends linearly on the acceleration voltage, indicated by the dashed line in Fig. 3.

At lower acceleration voltages space charge effects dominate which give rise to a square root like behavior: $\sigma_U \sim \sqrt{U}$. This can be understood as follows: The space charge expansion takes place on a time scale $\sim \omega_p^{-1}$ with $\omega_p = \sqrt{n_{i0} e^2/(m\epsilon_0)}$ the plasma frequency, $n_{i0}$ the initial peak ion density, $m$ the ion mass, and $\epsilon_0$ the permittivity of free space. In the region where the square root behavior appears, the bunches move so slowly that most of the internal (space charge) potential energy in the bunch has been converted into kinetic energy before it hits the detector. In that case for each particle the asymptotic velocity $v_{sp}$ due to the space charge expansion can be added to the velocity $v_0$ due to the accelerating fields. The energy spread is then given by

$$\sigma_U = \frac{1}{2} m (v_0^2 + v_{sp}^2 - \langle v_0 + v_{sp} \rangle^2) = m \sigma_{v_{sp}} \langle v_0 \rangle,$$  

where $\langle \rangle$ denotes averaging over all the particles and $\sigma_{v_{sp}}$ is the rms space charge expansion velocity. Since $v_0 \sim \sqrt{U}$ this model gives indeed the observed square root behavior.

The asymptotic space charge velocity $v_{sp}$ can be easily calculated for a uniform sphere. With a correction factor $\eta$ for the geometry this can be used to estimate the final space charge velocity for the Gaussian, cylindrically shaped bunch:

$$\sigma_{v_{sp}} = \eta \sqrt{2/3} \sigma_R \omega_p.$$  

In Fig. 3 the resulting model curve, obtained by combining Eq. (3) and (4) and taking $\eta = 0.4$, is indicated by a dotted line. It shows good agreement with the measured data. In the inset the separate curves for the different charges, without the scaling, are plotted together with the measured data.

In the crossover region around the intersection of the dashed and the dotted lines, where both space charge forces and the initial size contribute, an interesting effect occurs for large values of $\sigma_R$. In Fig. 4 $\sigma_U/U$ is plotted as a function of $U$ for $\sigma_R = 180$ $\mu$m and $\sigma_R = 32$ $\mu$m with, respectively, $Q = 0.5$ fC and $Q = 0.42$ fC. At high voltages we find that the relative energy spread goes to a constant value [Eq. (1)], which can indeed be controlled by changing the size of the ionization volume. This implies that even much lower relative energy spreads can be achieved than reported in this Letter by further reduction of the ionization laser beam waist. At the lowest voltages again space charge dominates, so $\sigma_U/U \propto U^{-1/2}$.

In the crossover region ($10$ eV $< U < 100$ eV), however, the relative energy spread for $\sigma_R = 180$ $\mu$m is significantly lower than the asymptotic high-voltage value. In this region space charge forces apparently give rise to a reduction of the relative energy spread. This counterintuitive effect can be understood as follows: in the high-energy regime, where space charge effects can be neglected, the particles in the back of the bunch acquire a higher velocity than the ones in front, simply because they are accelerated over a longer distance. In the low-energy space charge

![FIG. 3 (color). The five measured energy spread curves from Fig. 2 scaled by the bunch charge to a single curve. The simple analytical model given by Eq. (3) (dotted and solid lines) and Eq. (1) (dashed line) are plotted. The inset shows the data without the scaling.](image-url)
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